

Notice of References Cited	Application/Control No. 10/552,837		Applicant(s)/Patent Under Reexamination BEYER ET AL.	
	Examiner CHUN CHEUNG		Art Unit 3728	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,417,040	05-1995	Davoren, Gerrard A.	53/455
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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